Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/693,605	INUI ET AL.
Examiner	Art Unit

Alain L. Bashore

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
427	162-165	12/17/2007	AB	
430	321,394	12/17/2007	AB	
430	290	12/17/2007	ab	

SEARCH N (INCLUDING SEARC	OTES CH STRATEGY	
	DATE	EXMR
previous search updated	12/17/2007	АВ
inventor and assignee search	12/17/2007	ab